Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/823,581	CHEN ET AL.	
Examiner	Art Unit	
Scott L. Jarrett	3623	

	SEAR	CHED	
Class	Subclass	Date	Examiner

INT	ERFERENC	E SEARCH	ED
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SEARCH N (INCLUDING SEARC)
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